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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10023047	12/13/2001	117	90	1765	KUNEMUND, R

****APPLICANTS:** Kim Andrew; Fitzgerald Eugene;

****CONTINUING DATA VERIFIED:**

THIS APPLICATION IS A CON OF 09/449,217 11/24/1999 ABN
WHICH CLAIMS BENEFIT OF 60/109,619 11/24/1998

**** FOREIGN APPLICATIONS VERIFIED:**

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed ☐ yes ☐ no

35 USC 119 conditions met ☐ yes ☐ no

Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO

MIT8288CON

TITLE : Method of producing device quality (Al)InGaP alloys on lattice-mismatched substrates

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		Assistant Examiner	CLAIMS ALLOWED	
			Total Claims	Print Claim for O.G.
ISSUE FEE		Primary Examiner	DRAWING	
Amount Due	Date Paid		Sheets Drwg.	Figs. Drwg.
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE	Applicati n Examiner	
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